## Soft X-Ray, Deep UV Enhanced Series

**Inversion Layer Silicon Photodiodes** 

OSI Optoelectronics' 1990 R&D 100 award winning X-UV detector series are a unique class of silicon photodiodes designed for additional sensitivity in the X-Ray region of the electromagnetic spectrum without use of any scintillator crystals or screens. Over a wide range of sensitivity from 200 nm to 0.07 nm (6 eV to 17,600 eV), one electron-hole pair is created per 3.63eV of incident energy which corresponds to extremely high stable quantum efficiencies predicted by E(ph) /3.63eV (See graph below). For measurement of radiation energies above 17.6 keV, refer to the "Fully Depleted High Speed and High Energy Radiation Detectors" section.

A reverse bias can be applied to reduce the capacitance and increase speed of response. In the unbiased mode, these detectors can be used for applications requiring low noise and low drift. These detectors are also excellent choices for detecting light wavelengths between 350 to 1100 nm.

The detectors can be coupled to a charge sensitive preamplifier or low-noise op-amp as shown in the circuit on the opposite page.

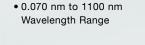
#### APPLICATIONS

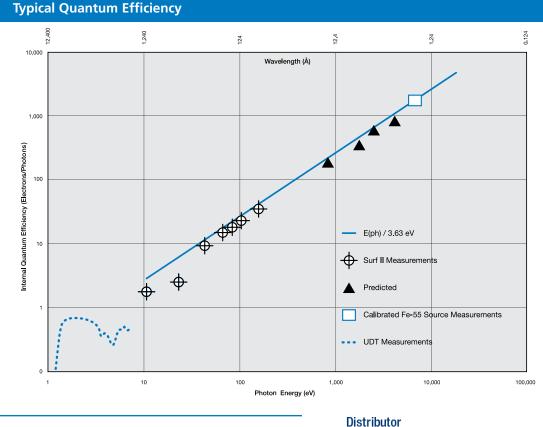
#### • Electron Detection

- Medical Instrumentation
- Dosimetry
- Radiation Monitoring
- X-ray Spectroscopy
- Charged Particle Detection

#### **FEATURES**

- Direct Detection
- No Bias Needed
- High Quantum Efficiency Low Noise
- High Vacuum Compatible • Cryogenically Compatible







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# Soft X-Ray, Deep UV Enhanced Photodiodes

Typical Electro-Optical Specifications at T<sub>A</sub>=23°C

| al Number | Active Area |               | Capacitance<br>(nF) |      | Shunt Resistance<br>(MΩ) |      | NEP<br>(W/√Hz) |      | Temp. Range*<br>(°C) |        |                    |
|-----------|-------------|---------------|---------------------|------|--------------------------|------|----------------|------|----------------------|--------|--------------------|
|           | m²)         | io            | 0 V                 |      | -10 mV                   |      | 0V<br>200 nm   |      | gui                  | e      | Package<br>Style ¶ |
| Mode      | vrea (m     | Dimens<br>(mm | typ.                | max. | min.                     | typ. | typ.           | max. | Operati              | Storaç |                    |

#### 'XUV' Series Metal Package

| XUV-005 | 5   | 2.57 ¢             | 0.3 | 0.5 | 200 | 2000 | 2.9 e -15 | 9.1 e -15 |       |       | 22 / TO-5 |
|---------|-----|--------------------|-----|-----|-----|------|-----------|-----------|-------|-------|-----------|
| XUV-020 | 20  | 5.00 ¢             | 1.2 | 1.6 | 50  | 500  | 5.8 e -15 | 1.8 e -14 | +60   | +80   | 23 / TO-8 |
| XUV-035 | 35  | 6.78 x 5.59        | 2   | 3   | 30  | 300  | 7.4 e -15 | 2.3 e -14 | -20 ~ | -20 ~ | 257 10 0  |
| XUV-100 | 100 | 11.33 <sup>¢</sup> | 6   | 8   | 10  | 100  | 7.4 e -15 | 4.1 e -14 |       |       | 28 / BNC  |

#### 'XUV' Series Ceramic Package

| XUV-50C  | 50  | 8.02 ¢   | 2 | 3 | 20 | 200 | 9.1 e -15 | 2.9 e -14 | +60   | +80   | 25 / Ceramic |
|----------|-----|----------|---|---|----|-----|-----------|-----------|-------|-------|--------------|
| XUV-100C | 100 | 10.00 sq | 6 | 8 | 10 | 100 | 1.3 e -14 | 4.1 e -14 | -20 ~ | -20 ~ | 25 / Ceramic |

 $\P$  For mechanical drawings please refer to pages 61 thru 73. All XUV devices are supplied with removable windows.

\* Non-Condensing temperature and Storage Range, Non-Condensing Environment.

#### **Circuit example**

In this circuit example, the pre-amplifier is a FET input op-amp or a commercial charge sensitive preamplifier. They can be followed by one or more amplification stages, if necessary. The counting efficiency is directly proportional to the incident radiation power. The reverse bias voltage must be selected so that the best signal-to-noise ratio is achieved.

For low noise applications, all components should be enclosed in a metal box. Also, the bias supply should be either simple batteries or a very low ripple DC supply.

Amplifier: OPA-637, OPA-27 or similar

 $R_F$ : 10 M $\Omega$  to 10 G $\Omega$ 

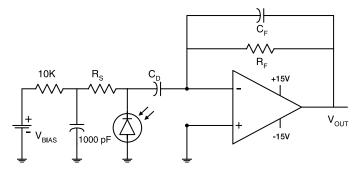
 $R_s$ : 1 M $\Omega$ ; Smaller for High Counting Rates

C<sub>F</sub>: 1pF

 $C_{D}$ : 1pF to 10  $\mu$ F

### OUTPUT $V_{OUT} = Q / C_F$

Where Q is the Charge Created By One Photon or One Particle



## **Photodiode Care and Handling Instructions**

#### AVOID DIRECT LIGHT

Since the spectral response of silicon photodiode includes the visible light region, care must be taken to avoid photodiode exposure to high ambient light levels, particularly from tungsten sources or sunlight. During shipment from OSI Optoelectronics, your photodiodes are packaged in opaque, padded containers to avoid ambient light exposure and damage due to shock from dropping or jarring.

#### **AVOID SHARP PHYSICAL SHOCK**

Photodiodes can be rendered inoperable if dropped or sharply jarred. The wire bonds are delicate and can become separated from the photodiode's bonding pads when the detector is dropped or otherwise receives a sharp physical blow.

#### **CLEAN WINDOWS WITH OPTICAL GRADE CLOTH / TISSUE**

Most windows on OSI Optoelectronics photodiodes are either silicon or quartz. They should be cleaned with isopropyl alcohol and a soft (optical grade) pad.

#### **OBSERVE STORAGE TEMPERATURES AND HUMIDITY LEVELS**

Photodiode exposure to extreme high or low storage temperatures can affect the subsequent performance of a silicon photodiode. Storage temperature guidelines are presented in the photodiode performance specifications of this catalog. Please maintain a non-condensing environment for optimum performance and lifetime.

#### **OBSERVE ELECTROSTATIC DISCHARGE (ESD) PRECAUTIONS**

OSI Optoelectronics photodiodes, especially with IC devices (e.g. Photops) are considered ESD sensitive. The photodiodes are shipped in ESD protective packaging. When unpacking and using these products, anti-ESD precautions should be observed.

#### DO NOT EXPOSE PHOTODIODES TO HARSH CHEMICALS

Photodiode packages and/or operation may be impaired if exposed to CHLOROTHENE, THINNER, ACETONE, or TRICHLOROETHYLENE.

#### **INSTALL WITH CARE**

Most photodiodes in this catalog are provided with wire or pin leads for installation in circuit boards or sockets. Observe the soldering temperatures and conditions specified below:

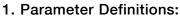
| Soldering Iron:        | Soldering 30 W or le<br>Temperature at tip o            | ess<br>of iron 300°C or lower.             |  |
|------------------------|---|--|--|
| Dip Soldering:         | Bath Temperature:<br>Immersion Time:<br>Soldering Time: | 260±5°C.<br>within 5 Sec.<br>within 3 Sec. |  |
| Vapor Phase Soldering: | DO NOT USE  |  |  |
| Reflow Soldering:      | DO NOT USE  |  |  |
|                        |   |  |  |

Photodiodes in plastic packages should be given special care. Clear plastic packages are more sensitive to environmental stress than those of black plastic. Storing devices in high humidity can present problems when soldering. Since the rapid heating during soldering stresses the wire bonds and can cause wire to bonding pad separation, it is recommended that devices in plastic packages to be baked for 24 hours at 85°C.

The leads on the photodiode **SHOULD NOT BE FORMED**. If your application requires lead spacing modification, please contact OSI Optoelectronics Applications group at (310)978-0516 before forming a product's leads. Product warranties could be voided.



\*Most of our standard catalog products are RoHS Compliant. Please contact us for details



- A = Distance from top of chip to top of glass.
- a = Photodiode Anode.
- B = Distance from top of glass to bottom of case.
- c = Photodiode Cathode
  - (Note: cathode is common to case in metal package products unless otherwise noted).
- W = Window Diameter.
- F.O.V. = Filed of View (see definition below).

### 2. Dimensions are in inches (1 inch = 25.4 mm).

- 3. Pin diameters are  $0.018 \pm 0.002$ " unless otherwise specified.
- 4. Tolerances (unless otherwise noted)

General: 0.XX ±0.01" 0.XXX ±0.005" Chip Centering: ±0.010" Dimension 'A': ±0.015"

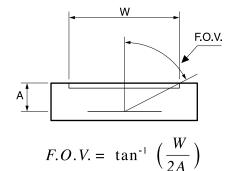
### 5. Windows

All **'UV'** Enhanced products are provided with QUARTZ glass windows,  $0.027 \pm 0.002$ " thick.

All 'XUV' products are provided with removable windows.

All 'DLS' PSD products are provided with A/R coated glass windows.

All 'FIL' photoconductive and photovoltaic products are epoxy filled instead of glass windows.

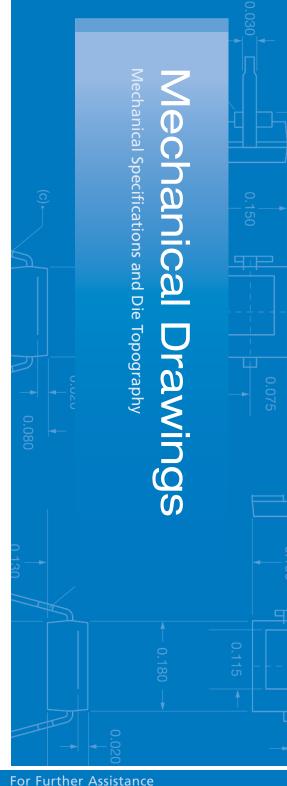






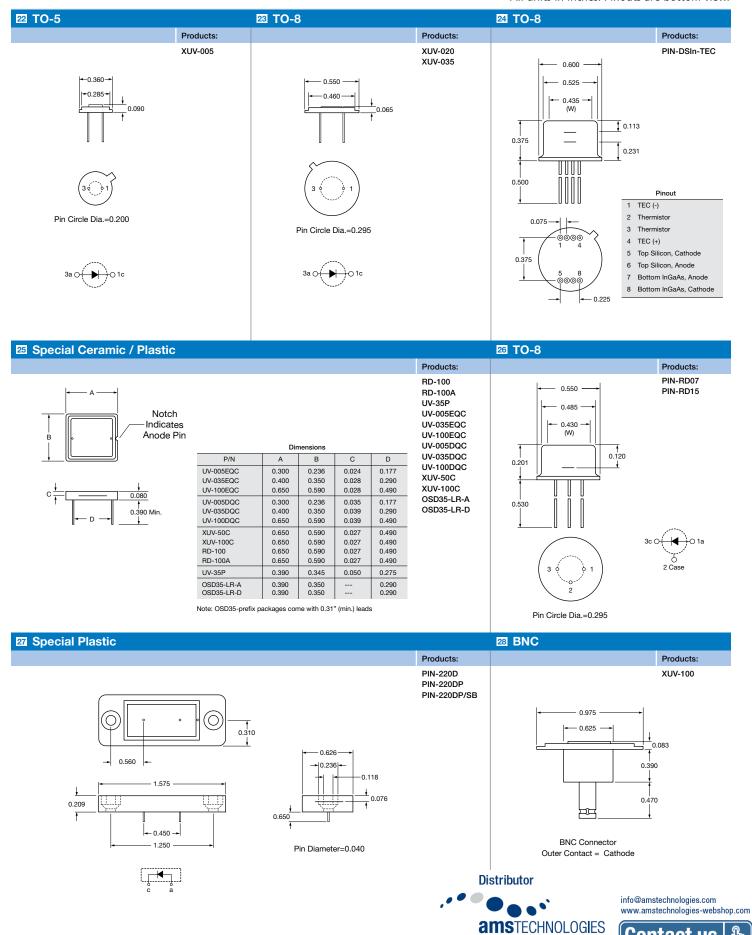
Please Call One of Our Experienced Sales and Applications Engineers

310-978-0516



## **Mechanical Specifications**

All units in inches. Pinouts are bottom view.



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where technologies meet solutions